Search Notes			

Application No.	Applicant(s)	
10/813,869	LEE ET AL.	
Examiner	Art Unit	
Yuwen Pan	2682	

SEARCHED			
Class	Subclass	Date	Examiner
453	41.2 502 574	1/20/05	yw
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	552		
	553.1		
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370	350		
	503		
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
455	41.2	1/20/05	Yw
	343. 1		1
	343.2		V

SEARCH NOT (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
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